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**Cards and security devices for  
personal identification — Contactless  
proximity objects —**

**Part 2:  
Radio frequency power and signal  
interface**

**AMENDMENT 1: Dynamic power level  
management**

*Cartes et dispositifs de sécurité pour l'identification personnelle —  
Objets sans contact de proximité —*

*Partie 2: Interface radiofréquence et des signaux de communication*

*AMENDEMENT 1: Gestion dynamique de niveau de puissance*



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